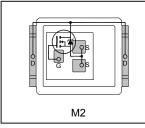
AUTOMOTIVE GRADE

AUIRF7675M2TR

Automotive DirectFET® Power MOSFET ②

- Advanced Process Technology
- Optimized for Class D Audio Amplifier Applications
- Low Rds(on) for Improved Efficiency
- Low Qg for Better THD and Improved Efficiency
- Low Qrr for Better THD and Lower EMI
- Low Parasitic Inductance for Reduced Ringing and Lower EMI
- Delivers up to 250W per Channel into 4Ω with No Heat sink
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Capability for Robustness and Reliability
- Lead free, RoHS and Halogen free
- Automotive Qualified *

$V_{(BR)DSS}$	150V
R _{DS(on)} typ.	47m $Ω$
max.	56m $Ω$
R _{g (typical)}	1.2Ω
Q _{g (typical)}	21nC





Applicable DirectFET® Outline and Substrate Outline ①

SB	SC		M2	M4	L4	L6	L8	

Description

The AUIRF7675M2TR/TR1 combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET packaging platform to produce a best in class part for Automotive Class D audio amplifier applications. The DirectFET package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET Power MOSFET optimizes gate charge, body diode reverse recovery and internal gate resistance to improve key Class D audio amplifier performance factors such as efficiency, THD and EMI. Moreover the DirectFET packaging platform offers low parasitic inductance and resistance when compared to conventional wire bonded SOIC packages which improves EMI performance by reducing the voltage ringing that accompanies current transients.

These features combine to make this MOSFET a highly desirable component in Automotive Class D audio amplifier systems.

Daga Dayt Newsbay	Dooks as Turns	Standard Pack		Ordershie Bert Normher
Base Part Number	Package Type	Form	Quantity	Orderable Part Number
AUIRF7675M2	DirectFET Medium Can	Tape and Reel	4800	AUIRF7675M2TR

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
V_{DS}	Drain-to-Source Voltage	150	V
V_{GS}	Gate-to-Source Voltage	±20	V
I_D @ T_C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) @	18	
$I_D @ T_C = 100^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) @	13	
$I_D @ T_A = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) 3	4.4	Α
I_D @ T_C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	90	
I _{DM}	Pulsed Drain Current ©	72	
P _D @T _C = 25°C	Power Dissipation ④	45	W
P _D @T _A = 25°C	Power Dissipation ③	2.7	VV
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ®	59	I
E _{AS} (Tested)	Single Pulse Avalanche Energy ®	170	mJ
I _{AR}	Avalanche Current ©	Coo Fig. 46, 47, 40a, 40b	Α
E _{AR}	Repetitive Avalanche Energy ®	See Fig. 16, 17, 18a, 18b	mJ
T _P	Peak Soldering Temperature	270	
TJ	Operating Junction and	-55 to + 175	°C
T _{STG}	Storage Temperature Range		

HEXFET® is a registered trademark of Infineon.

2015-12-14

^{*}Qualification standards can be found at www.infineon.com



Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ③		60	
$R_{ heta JA}$	Junction-to-Ambient ®	12.5		
$R_{\theta JA}$	Junction-to-Ambient ®	20		°C/W
$R_{ heta J ext{-Can}}$	Junction-to-Can 🐠 🕪		3.3	
$R_{\theta J\text{-PCB}}$	Junction-to-PCB Mounted	1.4		
	Linear Derating Factor ④	(0.3	

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	150			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.16		V/°C	Reference to 25°C, I _D = 1.0mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		47	56	mΩ	V _{GS} = 10V, I _D = 11A ⑦
$V_{GS(th)}$	Gate Threshold Voltage	3.0	4.0	5.0	V)/ -)/ - 100··A
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Coefficient		-11		mV/°C	$V_{DS} = V_{GS}$, $I_D = 100 \mu A$
gfs	Forward Transconductance	16			S	$V_{DS} = 50V, I_{D} = 11A$
R_G	Internal Gate Resistance		1.2	5.0	Ω	
	Drain to Source Leakage Current			20		$V_{DS} = 150V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			250	μΑ	V_{DS} = 150V, V_{GS} = 0V, T_{J} = 125°C
I _{GSS}	Gate-to-Source Forward Leakage			100	n 1	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

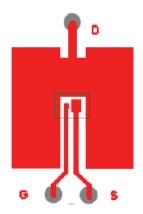
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge		21	32		V _{DS} = 75V
Q _{gs1}	Gate-to-Source Charge		5.2			V _{GS} = 10V
Q _{gs2}	Gate-to-Source Charge		1.6			I _D = 11A
Q _{gd}	Gate-to-Drain ("Miller") Charge		7.1		nC	See Fig. 6 and 17
Q _{godr}	Gate Charge Overdrive		7.1			
Q_{sw}	Switch Charge (Q _{gs2} + Q _{gd})		8.7			
Q _{oss}	Output Charge		8.8		nC	V _{DS} = 16V, V _{GS} = 0V
t _{d(on)}	Turn-On Delay Time		10			V _{DD} = 75V, V _{GS} = 10V ⑦
t _r	Rise Time		13			I _D = 11A
$t_{d(off)}$	Turn-Off Delay Time		14		ns	$R_G = 6.8\Omega$
t _f	Fall Time		7.5			
C _{iss}	Input Capacitance		1360			V _{GS} = 0V
C _{oss}	Output Capacitance		190			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		41		pF	f = 1.0 MHz
C _{oss}	Output Capacitance		1210			$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0 MHz$
C _{oss}	Output Capacitance		92		1	$V_{GS} = 0V, V_{DS} = 120V, f = 1.0MHz$

Notes ① through ⑩ are on page 3



Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I.	Continuous Source Current			18		MOSFET symbol
is	(Body Diode)			10	_	showing the
	Pulsed Source Current			70	A	integral reverse
Ism	(Body Diode) ©			72		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 11A, V_{GS} = 0V ?$
t _{rr}	Reverse Recovery Time		63	95	ns	$T_J = 25^{\circ}C, I_F = 11A, V_{DD} = 25V$
Q _{rr}	Reverse Recovery Charge		180	270	nC	dv/dt = 100A/µs ⑦



3 Surface mounted on 1 in. square Cu board (still air).



 Mounted to a PCB with small clip heatsink (still air)



 Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air).

- ${\mathbb O}$ Click on this section to link to the appropriate technical paper. ${\mathbb O}$ Click on this section to link to the DirectFET $^{\! @}$ Website.
- 3 Surface mounted on 1 in. square Cu board, steady state.
- ④ T_C measured with thermocouple mounted to top (Drain) of part.
- © Repetitive rating; pulse width limited by max. junction temperature.
- ⑥ Starting $T_J = 25$ °C, L = 1.33mH, $R_G = 50$ Ω, $I_{AS} = 11$ A.
- $\ \ \$ Pulse width $\le 400 \mu s$; duty cycle $\le 2\%$.
- ® Used double sided cooling, mounting pad with large heatsink.
- Mounted on minimum footprint full size board with metalized back and with small clip heat sink.
- @ R_{θ} is measured at T_J of approximately 90°C.

2015-12-14



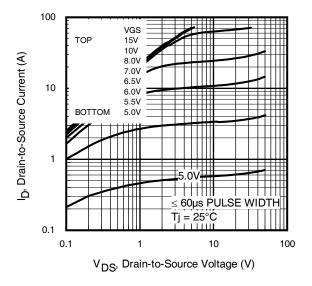


Fig. 1 Typical Output Characteristics

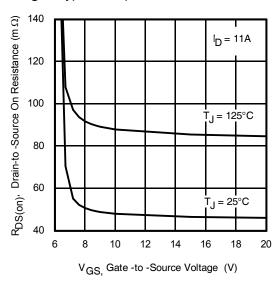


Fig. 3 Typical On-Resistance vs. Gate Voltage

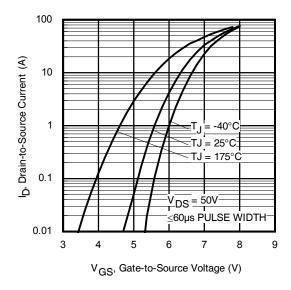


Fig 5. Transfer Characteristics

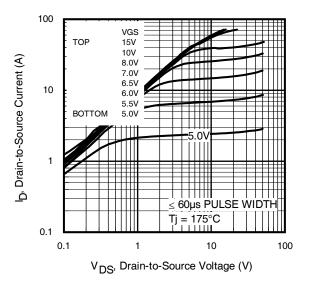


Fig. 2 Typical Output Characteristics

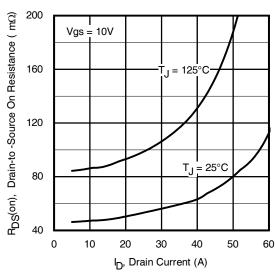


Fig. 4 Typical On-Resistance vs. Drain Current

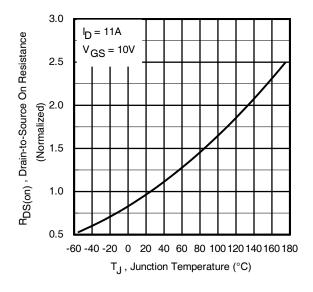


Fig 6. Normalized On-Resistance vs. Temperature



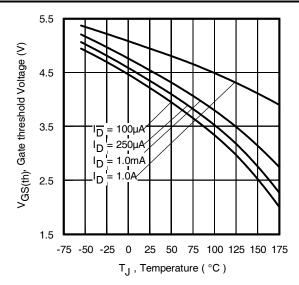


Fig. 7 Typical Threshold Voltage vs. Junction Temperature

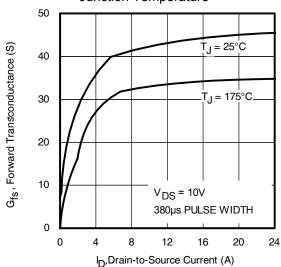


Fig 9. Typical Forward Trans conductance vs. Drain Current

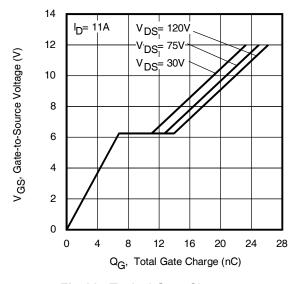


Fig 11. Typical Gate Charge vs. Gate-to-Source Voltage

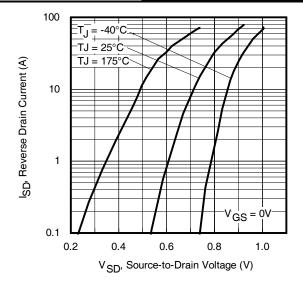


Fig 8. Typical Source-Drain Diode Forward Voltage

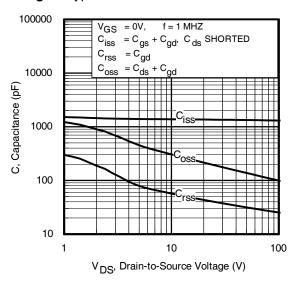


Fig 10. Typical Capacitance vs. Drain-to-Source Voltage

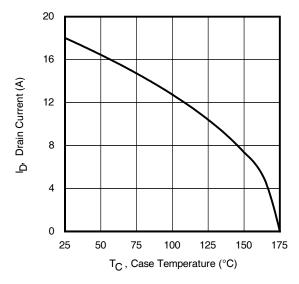
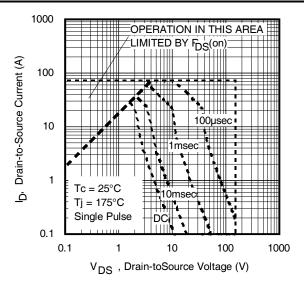


Fig 12. Maximum Drain Current vs. Case Temperature





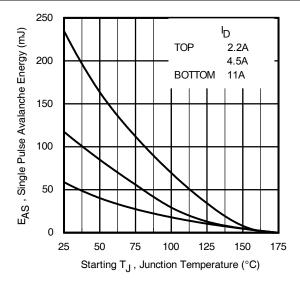


Fig 13. Maximum Safe Operating Area

Fig 14. Maximum Avalanche Energy vs. Temperature

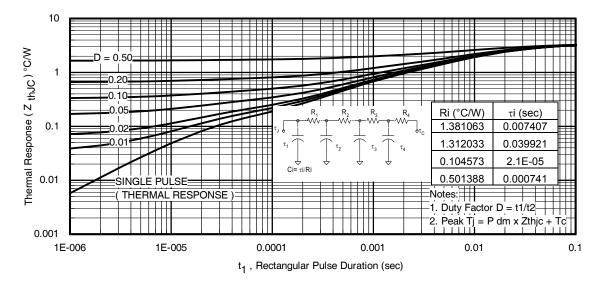


Fig 15. Maximum Effective Transient Thermal Impedance, Junction-to-Case

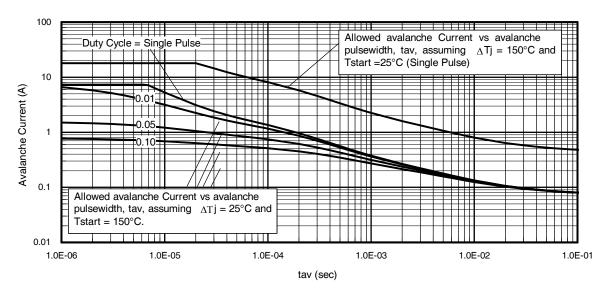


Fig 16. Typical Avalanche Current vs. Pulse Width



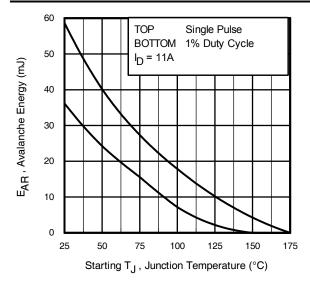


Fig 17. Maximum Avalanche Energy vs. Temperature

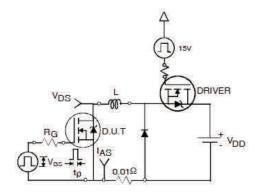


Fig 18a. Unclamped Inductive Test Circuit

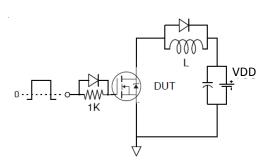


Fig 19a. Gate Charge Test Circuit

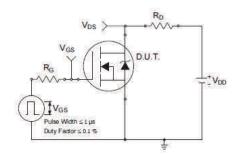


Fig 20a. Switching Time Test Circuit

Notes on Repetitive Avalanche Curves, Figures 16, 17: (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. lav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 16, 17).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 15)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ (} 1.3 \cdot \text{BV} \cdot \text{I}_{av} \text{)} = \Delta \text{T} / \text{Z}_{thJC} \\ I_{av} &= 2\Delta \text{T} / \text{ [} 1.3 \cdot \text{BV} \cdot \text{Z}_{th} \text{]} \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

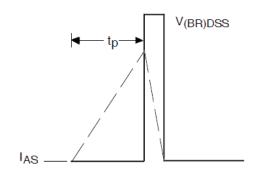


Fig 18b. Unclamped Inductive Waveforms

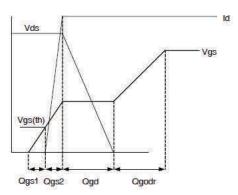


Fig 19b. Gate Charge Waveform

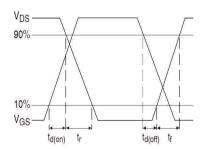
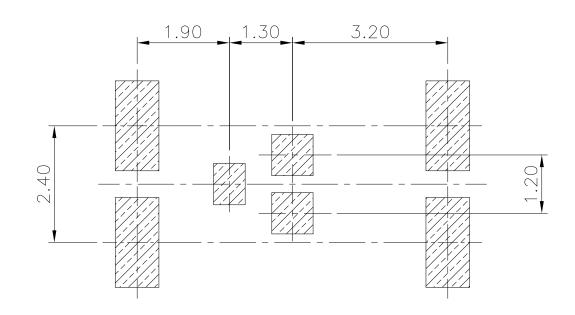


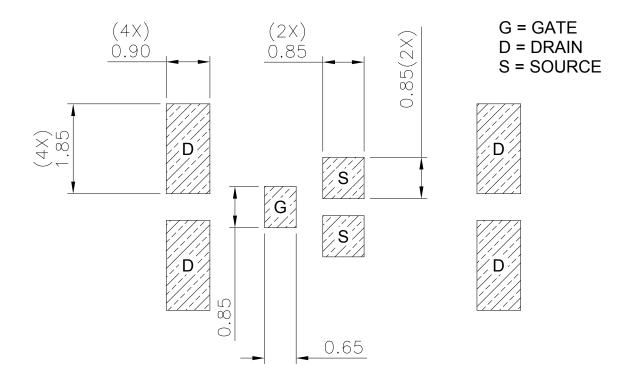
Fig 20b. Switching Time Waveforms



DirectFET® Board Footprint, M2 (Medium Size Can).

Please see DirectFET® application note AN-1035 for all details regarding the assembly of DirectFET®. This includes all recommendations for stencil and substrate designs.



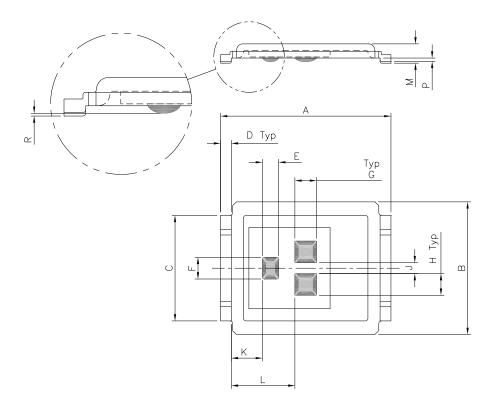


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



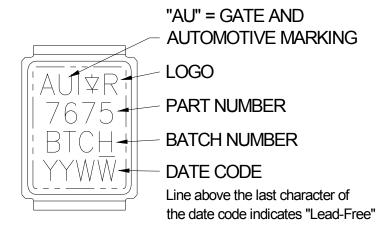
DirectFET® Outline Dimension, M2 Outline (Medium Size Can).

Please see DirectFET® application note AN-1035 for all details regarding the assembly of DirectFET® . This includes all recommendations for stencil and substrate designs.



	DIMENSIONS						
	MET	RIC	IMPE	RIAL			
CODE	MIN	MAX	MIN	MAX			
Α	6.25	6.35	0.246	0.250			
В	4.80	5.05	0.189	0.199			
С	3.85	3.95	0.152	0.156			
D	0.35	0.45	0.014	0.018			
Е	0.58	0.62	0.023	0.024			
F	0.78	0.82	0.031	0.032			
G	0.78	0.82	0.031	0.032			
Н	0.78	0.82	0.031	0.032			
- 1	N/A	N/A	N/A	N/A			
J	0.38	0.42	0.015	0.017			
K	1.10	1.20	0.043	0.047			
L	2.30	2.40	0.090	0.094			
М	0.68	0.74	0.027	0.029			
Р	0.09	0.17	0.003	0.007			
R	0.02	0.08	0.001	0.003			

DirectFET® Part Marking

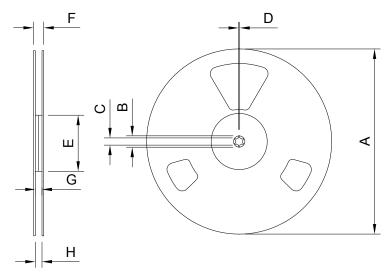


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



DirectFET® Tape &

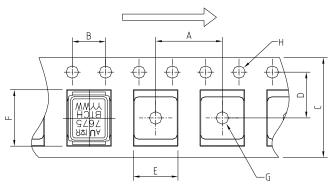
Reel Di-



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts, order as AUIRF7675M2TR.

	REEL DIMENSIONS						
S.	TANDARI	O OPTION	(QTY 48	00)			
	ME	TRIC	IMP	ERIAL			
CODE	MIN	MAX	MIN	MAX			
Α	330.0	N.C	12.992	N.C			
В	20.2	N.C	0.795	N.C			
С	12.8	13.2	0.504	0.520			
D	1.5	N.C	0.059	N.C			
Е	100.0	N.C	3.937	N.C			
F	N.C	18.4	N.C	0.724			
G	12.4	14.4	0.488	0.567			
Н	11.9	15.4	0.469	0.606			

Loaded Tape Feed Direction



	DIMENSIONS						
NOTE: CONTROLLING		М	ETRIC	IMI	PERIAL		
DIMENSIONS IN MM	CODE	MIN	MAX	MIN	MAX		
	Α	7.90	8.10	0.311	0.319		
	В	3.90	4.10	0.154	0.161		
	С	11.90	12.30	0.469	0.484		
	D	5.45	5.55	0.215	0.219		
	E	5.10	5.30	0.201	0.209		
	F	6.50	6.70	0.256	0.264		
	G	1.50	N.C	0.059	N.C		
	Н	1.50	1.60	0.059	0.063		

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

Qualification Level		Automotive				
		(per AEC-Q101)				
		Comments: This part number(s) pas	sed Automotive qualification. Infineon's			
		Industrial and Consumer qualification le	evel is granted by extension of the higher			
		Automotive level.				
Moisture	Sensitivity Level	DFET2 Medium Can	MSL1, 260°C			
	Machine Madel	Class M4 (+/- 400V) [†]				
	Machine Model	AEC-Q101-002				
FOD	Liver on Dady Madal	Class H1B (+/- 1000V) [†]				
ESD	Human Body Model	AEC-Q101-001				
	Observed Basis a Madal	Class C4 (+/- 1000V) [†]				
Charged Device Model		AEC-Q101-005				
RoHS Compliant		Yes				

[†] Highest passing voltage.

Revision History

Date	Comments
12/14/2015	 Updated datasheet with corporate template Corrected ordering table on page 1. Updated Tape and Reel option on page 10

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